

# SIDC24D30SIC3

## Silicon Carbide Schottky Diode

### **FEATURES:**

- Revolutionary semiconductor material -Silicon Carbide
- Switching behavior benchmark
- No reverse recovery
- No temperature influence on the switching behavior
- No forward recovery

## Applications:

SMPS, snubber, secondary side rectification



Chip Type	$V_{BR}$	I <sub>F</sub>	Die Size	Package	Ordering Code
SIDC24D30SIC3	300V	10A	1.706 x 1.38 mm <sup>2</sup>	sawn on foil	Q67050-A4163- A103

#### **MECHANICAL PARAMETER:**

1.706x 1.38 1.405 x 1.08 2.354 / 1.548 355	mm mm²			
2.354 / 1.548				
	mm <sup>2</sup>			
355				
	μm			
75	mm			
0	deg			
1649 pcs				
Photoimide				
3200 nm Al				
1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Electrically conductive glue or solder				
AI, ≤ 350μm				
Ø ≥ 0.3 mm				
store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				
	75  0  1649 pcs  Photoimide  3200 nm Al  1400 nm Ni Ag –system suitable for epoxy and soft solder die  Electrically conductive glue or so  Al, $\leq$ 350 $\mu$ m $\emptyset \geq$ 0.3 mm  store in original container, in dry nit			



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## **Maximum Ratings**

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	$V_{RRM}$		300	\/
Surge peak reverse voltage	V <sub>RSM</sub>		300	1 °
Continuous forward current limited by $T_{jmax}$	I <sub>F</sub>		10	
Single pulse forward current (depending on wire bond configuration)	I <sub>FSM</sub>	$T_C = 25^{\circ}C$ , $t_P = 10$ ms sinusoidal	36	А
Maximum repetitive forward current limited by T <sub>jmax</sub>	I <sub>FRM</sub>	$T_C = 100$ °C, $T_j = 150$ °C, $D = 0.1$	45	
Non repetitive peak forward current	I <sub>FMAX</sub>	$T_C = 25^{\circ}C$ , $tp = 10\mu s$	100	
Operating junction and storage temperature	$T_{\rm j}$ , $T_{ m stg}$		-55+175	°C

## $\textbf{Static Electrical Characteristics} \text{ (tested on chip)}, \ \textit{T}_{j}\text{=-}25 \ ^{\circ}\text{C}, \text{ unless otherwise specified}$

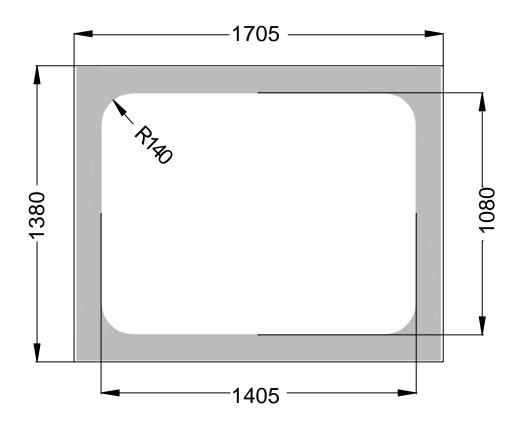
Parameter	Symbol	Condi	Value			Unit	
raiailletei	Syllibol	Condi	itions	min.	Тур.	max.	
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> =300V	<i>T<sub>j</sub></i> =25 °C		15	200	μΑ
Forward voltage drop	V <sub>F</sub>	I <sub>F</sub> =10A	<i>T<sub>j</sub></i> =25°C		1.5	1.7	V

## **Dynamic Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions		Value			Unit
raiailletei	Syllibol			min.	Тур.	max.	Unit
Total capacitive charge	$Q_C$	$I_F=10A$ di/dt=200A/ms $V_R=200V$	$T_j = 150  ^{\circ}\text{C}$		23		nC
Switching time	t <sub>rr</sub>	$I_F=10A$ di/dt=200A/ms $V_R=200V$	$T_j = 150  ^{\circ}\text{C}$		n.a.		ns
Total capacitance	С	$I_F=10A$ di/dt=200A/ms $T_j=25^{\circ}C$ f=1MHz	$V_R = 1 V$		600		
			V <sub>R</sub> =150V		55		pF
			V <sub>R</sub> =300V		40		



## **CHIP DRAWING:**





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#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet

INFINEON TECHNOLOGIES

SDP10S30

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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